Docket No.: 005920 USA/MTCG/PCTRL/JW

PATENT/OFFICIAL

IN THE UNITED STATES PATENT

In re Application of

SHANMUGASUNDRAM et al.

Serial No. 09/943,383

Group Art Unit: 2862

Filed: August 31, 2001

Examiner: William David Coleman

For:

IN SITU SENSOR BASED CONTROL OF SEMICONDUCTOR PROCESSING

PROCEDURE

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Honorable Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the document listed on the attached form PTO-1449. It is respectfully requested that this document be expressly considered during the prosecution of this application, and that the document be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This submission does not constitute a representation that a search has been made or that no better art exists and does not constitute an admission or representation that any of the listed documents is material or constitutes prior art. If it should be determined that any of the listed documents does not constitute prior art under the United States law, Applicants reserve the right

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Serial No. 09/943,383

to present to the Office the relevant facts and law regarding the appropriate status of such

document.

Applicant petitions for consideration of the enclosed documents by the Examiner. No

item of information contained in the information disclosure statement was cited in a

communication from a foreign patent office in a counterpart foreign application, and, to the

knowledge of the person signing this certification, after making reasonable inquiry, no item of

information contained in the information disclosure statement was known to any individual

designated in § 1.56(c) more than three months prior to the filing of the information disclosure

statement.

The petition fee of \$180.00 pursuant to 37 CFR § 1.17(p) is attached. The Commissioner

is authorized to charge any deficiency in any fees pursuant to 37 CFR § 1.17 associated with this

communication and to credit any excess payment to Deposit Account No. 08-0219.

Respectfully submitted,

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SHEET 1 OF 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION	ATTY. DOCKET NO. 005920 USA/MTCG/PCTRL/JW	SERIAL NO. 09/943,383
(PTO-1449)	APPLICANT SHANMUGASUNDRAM	et al.
	FILING DATE August 31, 2001	GROUP 2823
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)

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SHANMUGASUNDRAM et al.

FILING DATE August 31, 2001 GROUP 2823

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Applicant(s):

SHANMUGASUNDRAM et al. Application: 09/943,383 107262.149

Filing Date:

August 31, 2001

Atty Docket No.: 5920 USA/MTCG/PCTRL/JW

Entitled:

In Situ Sensor Based Control of Semiconductor Processing Procedure

RECEIPT IS ACKNOWLEDGED FOR THE FOLLOWING:

[X] Supplemental Information Disclosure Statement and Form PTO-1449

[X] 12 References

[X] Authorization to charge Deposit Account No. 08-0219 for \$180.00



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Applicant(s):

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